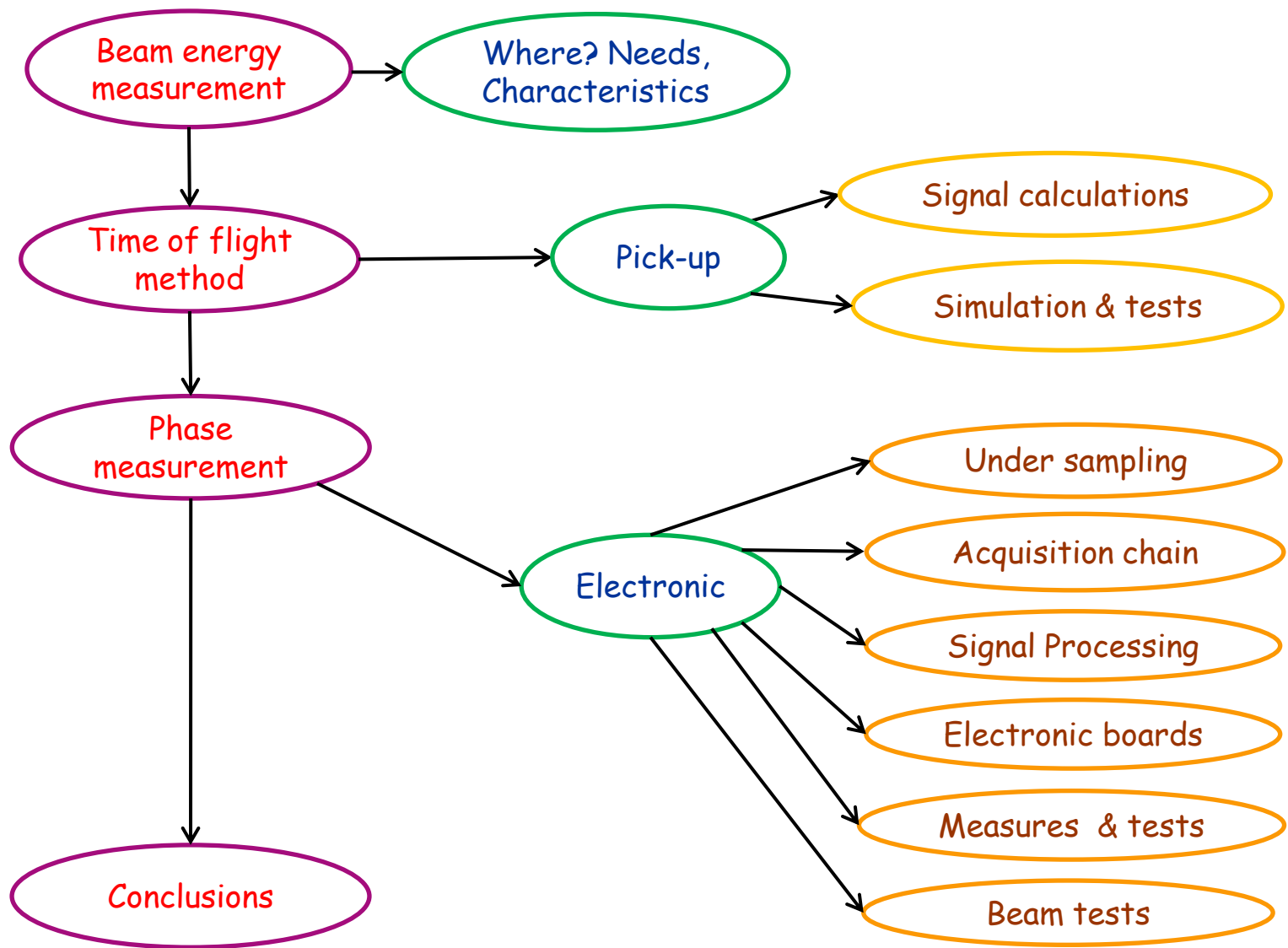


Beam energy measurement on the SPIRAL2 accelerator

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*Christophe JAMET
jamet@ganil.fr*

SPIRAL: Linearly Accelerated Radioactive Ion Production System



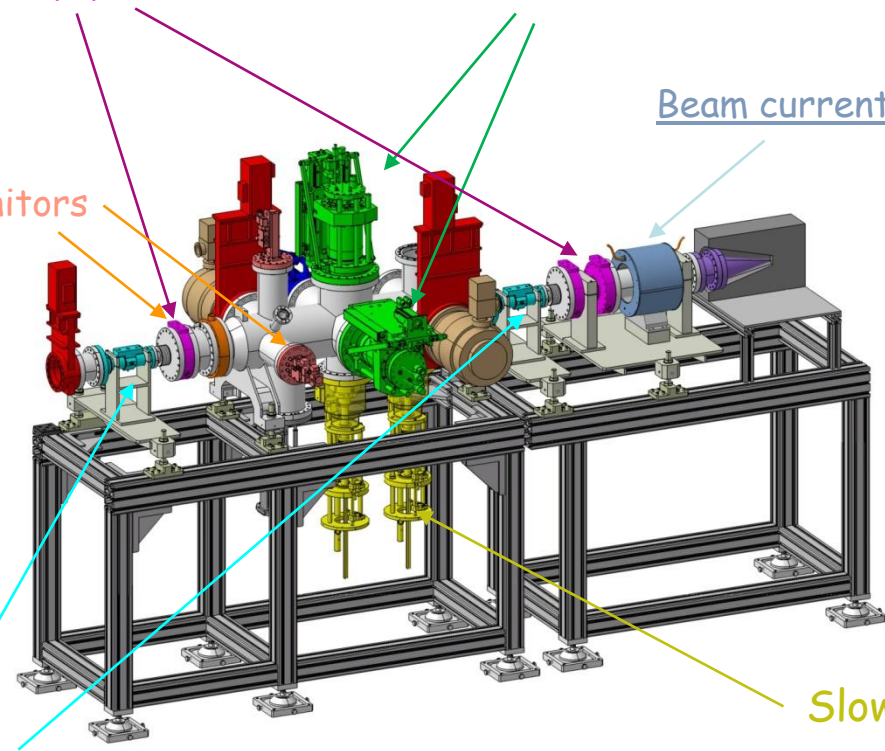
Two beam energy measurements are planned on the SPIRAL2 accelerator. The first device will be installed on the Intermediate Test Bench (ITB) downstream the RFQ and the re-buncher 1. The ITB will be used to qualify the beam at the exit of the RFQ (*).

Phase and energy: three P.U. electrodes

Transverse emittance: Allison scanner

Beam current: D.C.C.T. and A.C.C.T.

- Beam transverse profiles:
- Secondary emission and
- residual ionization gas monitors

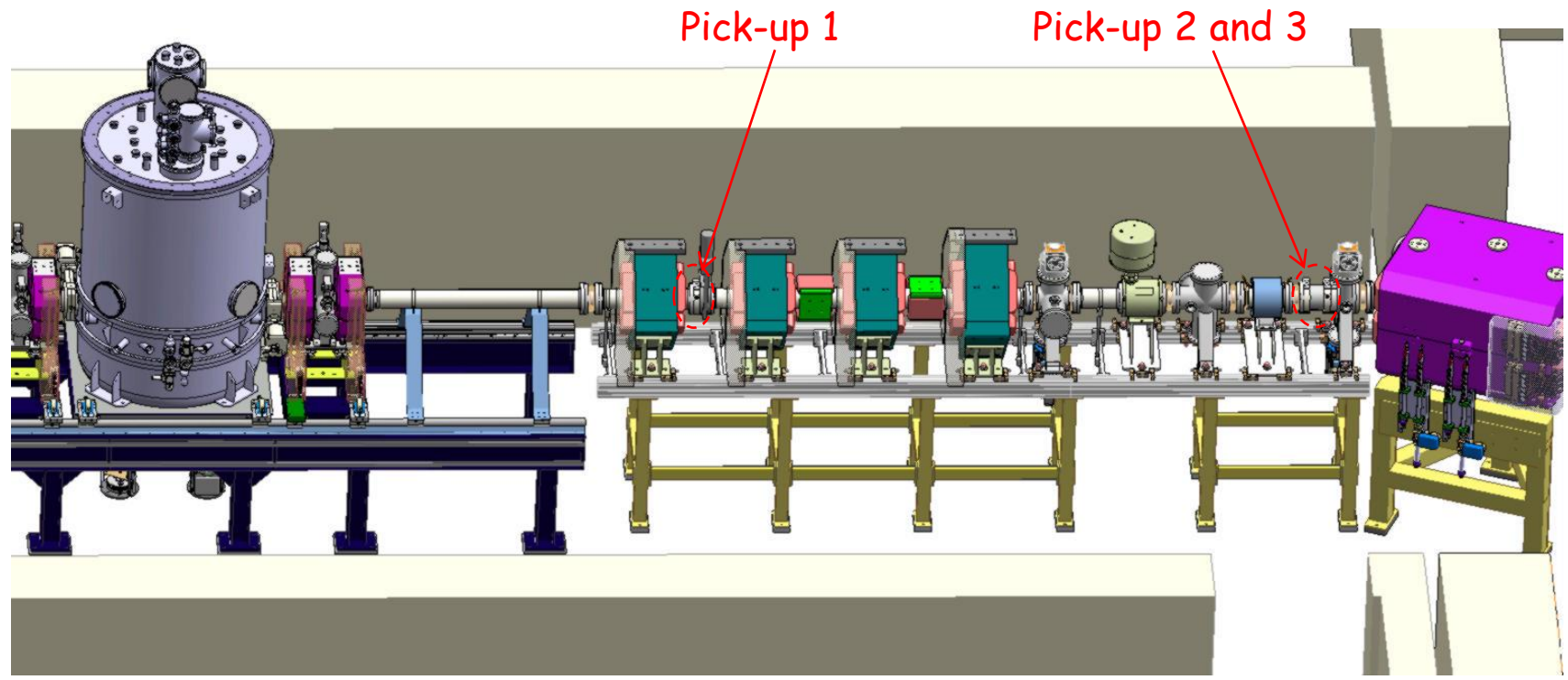


Beam Position P.U.

Slow Faraday cup

* See the Ditonet presentation of P. Ausset on the SPIRAL 2 accelerator diagnostics , the 26th September 2011

A second measure of energy by time of flight will be done at the exit of the linac in the HEBT line.



The length between Pick-up1 and 2 is around 3,9 m.

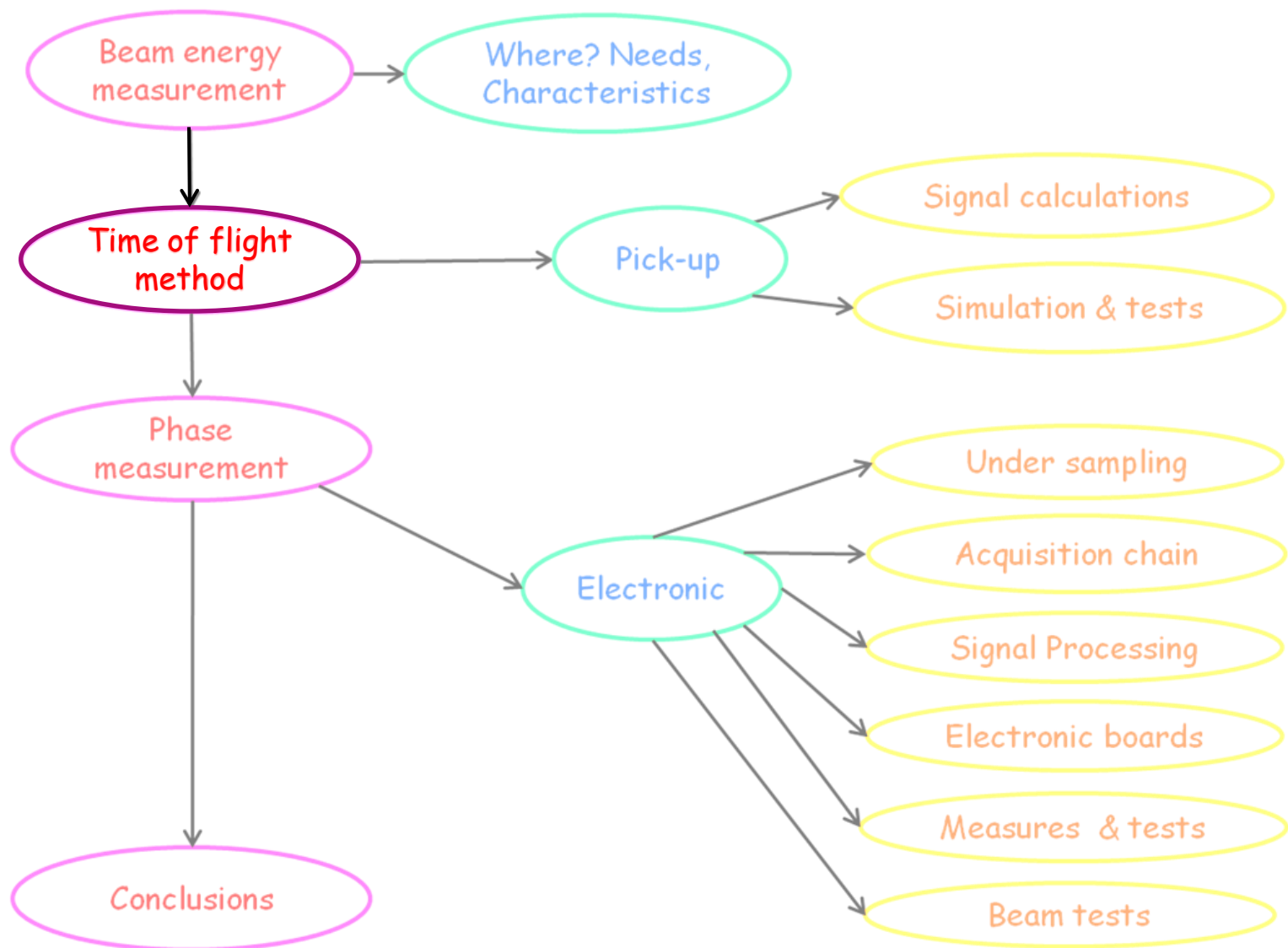


MEBT and HEBT Beam characteristics

The SPIRAL2 accelerator is designed to accelerate ions ($q/A=1/3$), deuterons and protons.

		MEBT	HEBT
Energy	E (MeV/A)	0,75	2 to 20 *
Velocity	$\beta=v/c$	0,04	0,065 to 0,2
Frequency	F_{acc} (MHz)	88,05	88,05
Period (ns)		11,35	11,35
Length	L_{acc} (cm)	13,6	22 to 68
Length	L_{12} (m)	1,5	3,9
Bunch Number		11	5 to 17
Pick-up diameter	(mm)	80	120

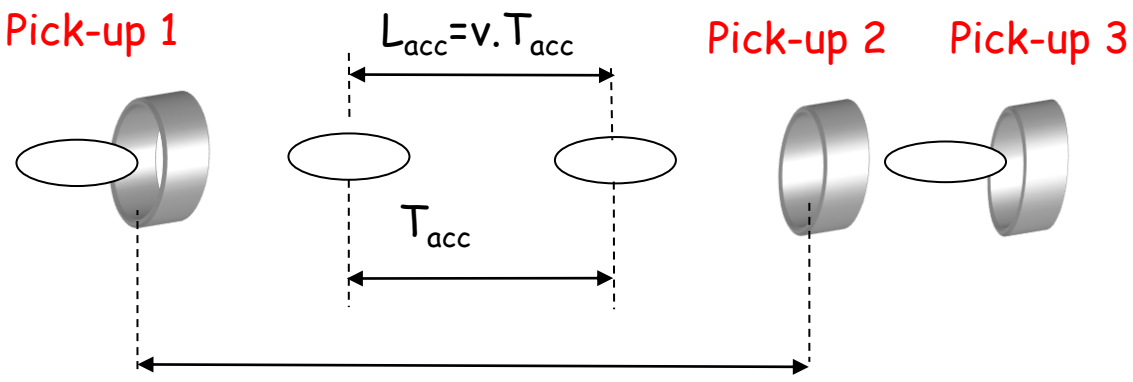
* HEBT energy: min: 2MeV (proton) max: 20 MeV/A (deuteron)



The Time of Flight Method consists in measuring the time difference between signals produce by bunches on two pick-ups. If the length between pick-ups is well known, the velocity is given by:

$$V = \frac{Lenght}{Time}$$

The Time can be calculated from the pick-up phase. $t = T_{acc} * \frac{\varphi}{360}$



$$T_{12} = N \cdot T_{acc} + \delta t_{12} = T_{acc} (N + \delta\varphi_{12}/360)$$

$$T_{12} = T_{acc} (N + \frac{\delta\varphi_{12}}{360})$$

But we have to take account the number of bunches included between the first two pick-ups. The third pick-up is used to determine this number N of bunches.

The distance between the pick-up 2 and 3 is chosen to have :

$$L_{23} < L_{acc} \quad \frac{\varphi_{23}}{360} = \frac{L_{23}}{L_{acc}} \quad L_{acc} = L_{23} * \frac{360}{\varphi_{23}}$$

Steps to calculate the beam energy:

1 Number of bunches $N = \text{integer}\left(\frac{L_{12}}{L_{acc}}\right) = \text{integer}\left(\frac{L_{12}}{L_{23}} \cdot \frac{360}{\varphi_{23}}\right)$

2 Time between Pick-up 1 and 2 $T_{12} = T_{acc} \left(N + \frac{\delta\varphi_{12}}{360}\right)$

3 Velocity $v = \frac{L_{12}}{T_{12}} = \frac{L_{12}}{T_{acc} \left(N + \frac{\varphi_{12}}{360}\right)} = 360 \cdot \frac{L_{12}}{360 \cdot N + \varphi_{12}} \cdot F_{acc}$

4 Lorentz factor $\gamma = \frac{1}{\sqrt{1 - \left(\frac{v}{c}\right)^2}}$

5 Beam Energy per nucleon $\left(\frac{E}{A}\right)_{MeV} = \frac{\text{ion_masse}}{A} E m_u (\gamma - 1)$

[2] Lecture Notes on Beam Instrumentation and Diagnostics - Peter Fork (GSI) – JUAS 01-03-2006

[3] Beam Instrumentation and Diagnostics – Peter Strehl – Editeur Springer Berlin 2006

The accuracy is given by the formula:

$$E \approx \frac{1}{2}mv^2 = \frac{1}{2}m\left(\frac{L}{T}\right)^2 \quad \left|\frac{\Delta E}{E}\right| = 2\sqrt{\left(\frac{\Delta L}{L}\right)^2 + \left(\frac{\Delta T}{T}\right)^2} = 2\sqrt{\left(\frac{\Delta L}{L}\right)^2 + \left(\frac{\Delta(\delta\varphi)}{360N + \Delta(\delta\varphi)}\right)^2}$$

For SPIRAL2, the required accuracy of the energy is 0,2 percent.

$$\sqrt{\left(\frac{\Delta L}{L}\right)^2 + \left(\frac{\Delta(\delta\varphi)}{360N + \Delta(\delta\varphi)}\right)^2} = \frac{1}{1000}$$

$$\left(\frac{\Delta L}{L}\right)^2 + \left(\frac{\Delta(\delta\varphi)}{360N + \Delta(\delta\varphi)}\right)^2 = 10^{-6}$$

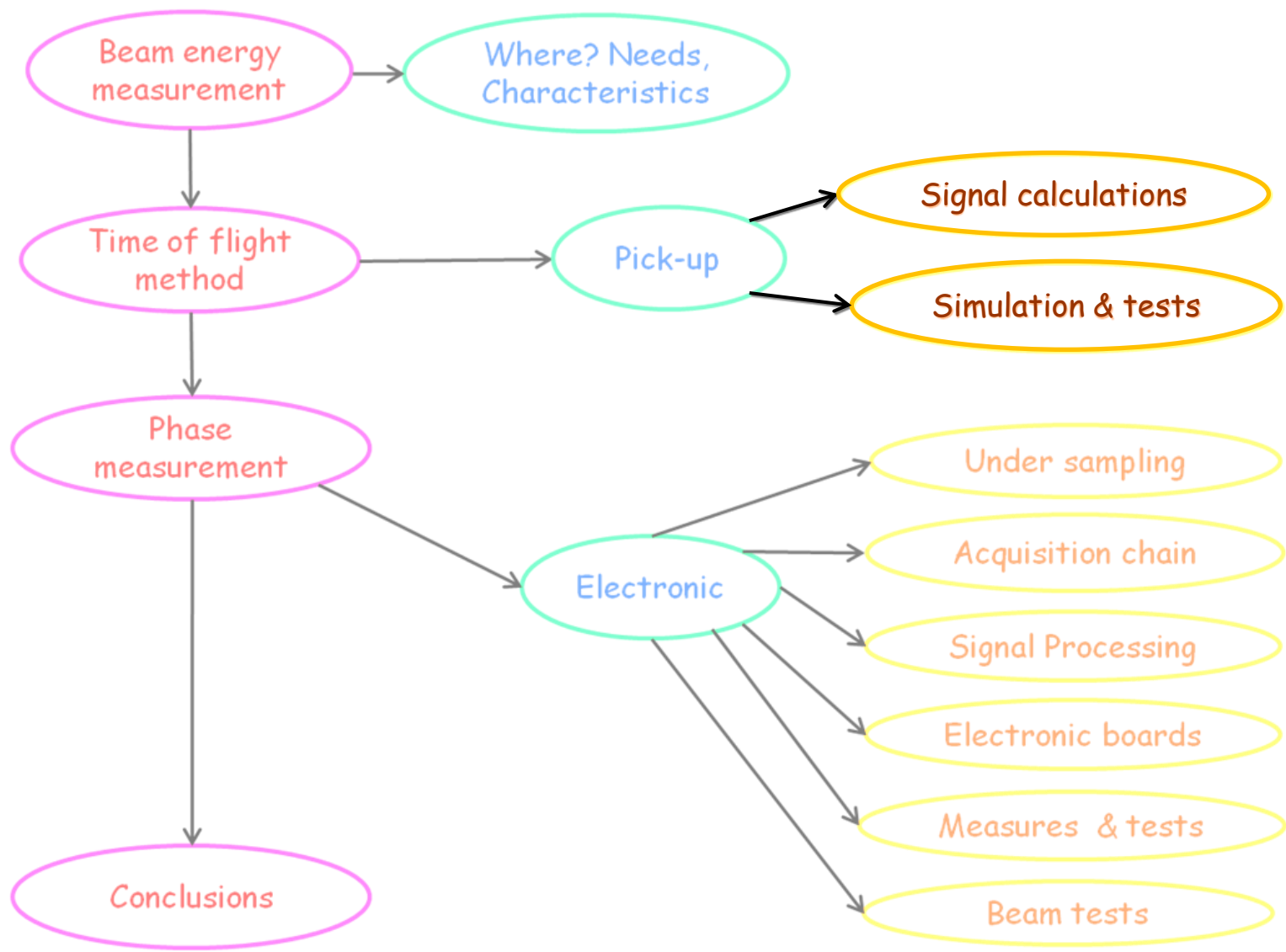
ITB accuracy

$$L = 1,5m \quad \left(\frac{\Delta L}{L}\right)^2 = 0,5 \cdot 10^{-6} \quad \Delta L \approx 1mm$$

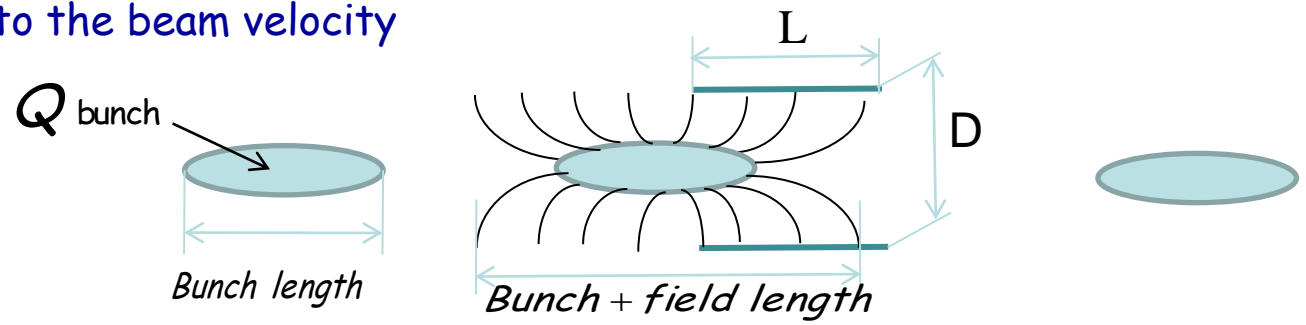
$$\left(\frac{\Delta(\delta\varphi)}{360N + \Delta(\delta\varphi)}\right)^2 = 0,5 \cdot 10^{-6} \quad \Delta(\delta\varphi) \approx \sqrt{0,5 \cdot 10^{-6}} \cdot 360 \cdot N$$

$$N \approx \frac{1,5}{13,6 \cdot 10^{-2}} \approx 11 \quad \Delta(\delta\varphi) \approx \sqrt{0,5 \cdot 10^{-6}} \cdot 360 \cdot 11 = 2,8^\circ$$

For the ITB, the distance has to be known with an accuracy better than 1 mm and a phase better than 2,8°.



Electromagnetic effect on the pick-up signal due to beam pipe diameter and to the beam velocity



Beam intensity

$$Ib(t) = \frac{Q_{bunch} \cdot e^{-\frac{t^2}{2\sigma t^2}}}{\sigma t \sqrt{2\pi}}$$

$$\sigma t_{total} = \sqrt{\sigma t_{bunch}^2 + \sigma t_{field}^2}$$

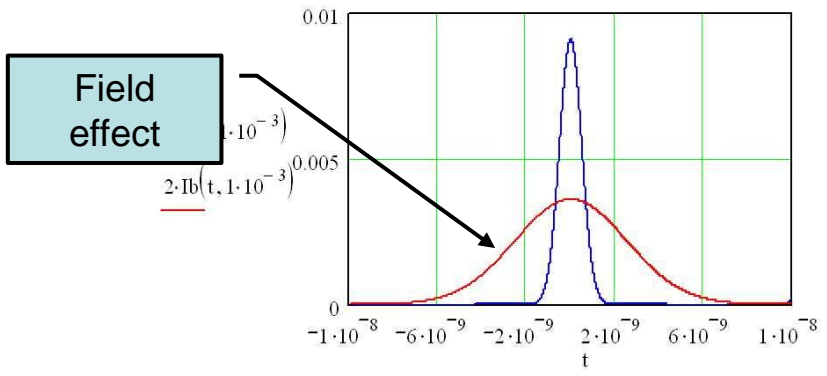
$$\sigma t_{field} = \frac{D}{2\sqrt{2} \cdot \gamma \cdot \beta \cdot c}$$

On the ITB:

$$\sigma t_{bunch} = 0,5 \cdot 10^{-9} s$$

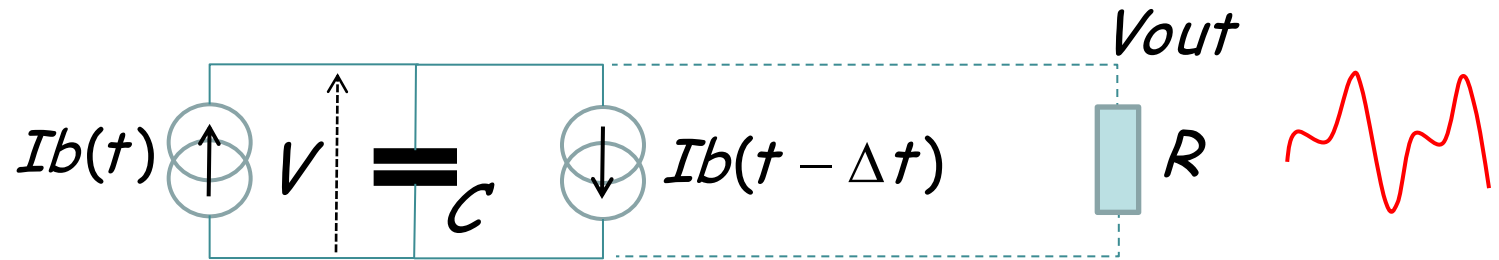
$$D = 84mm \quad \sigma t_{field} = 2,5 \cdot 10^{-9} s$$

Simulation for 1mA beam



The beam effect on the electrode can be described by two current sources, one for the beam entering and one for the beam leaving the electrode separated by a delay $\Delta t = L/v$

This gives the following electric equivalent scheme:



The expression of the voltage across the load R is:

$$V_{out}(t) = \frac{e^{-\frac{t}{RC}}}{C} \int_0^t [I_b(x) - I_b(x - \frac{L}{v})] \cdot e^{\frac{x}{RC}} dx$$

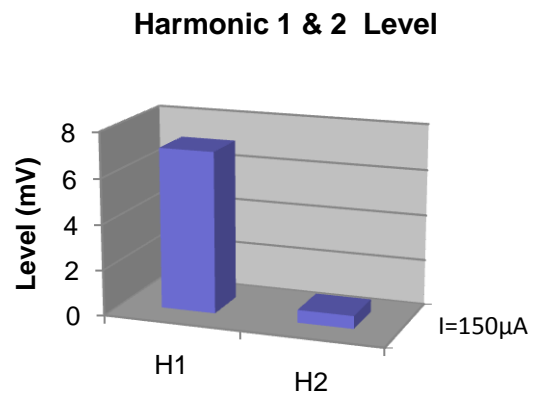
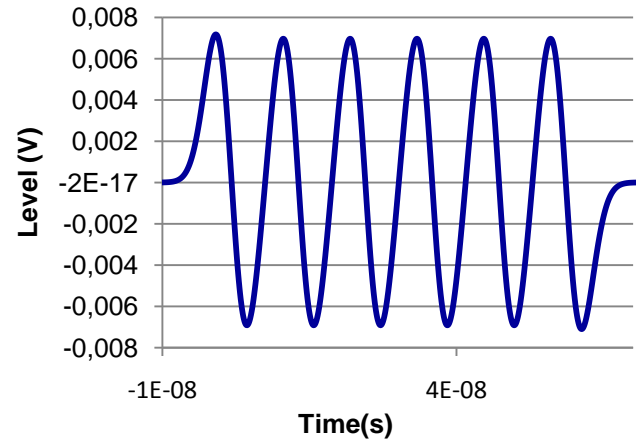
On the ITB:

$C \sim 8,8 \text{ pF}$ $RC \sim 0,44 \cdot 10^{-9} \text{ s}$

[1] Beam Instrumentation, J.Bosser, CERN-PE-ED001-92 Revised nov.1994

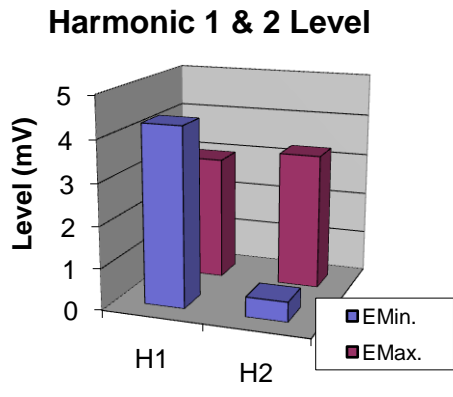
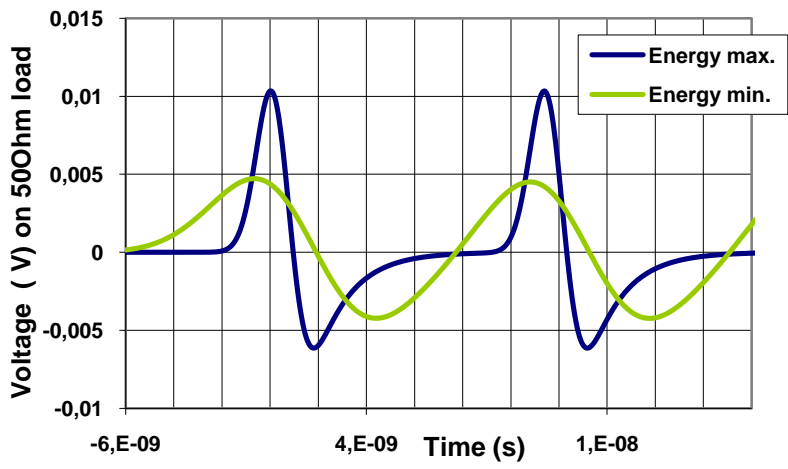
Pick-up signal simulation with Ibeam=150μA

in MEBT Ø80mm



In MEBT, only H1 detection can be used.

in HEBT Ø120mm



In HEBT, H1 or H2 detection can be used. To cover the whole Spiral2 energy range, H1 detection is the most suitable.

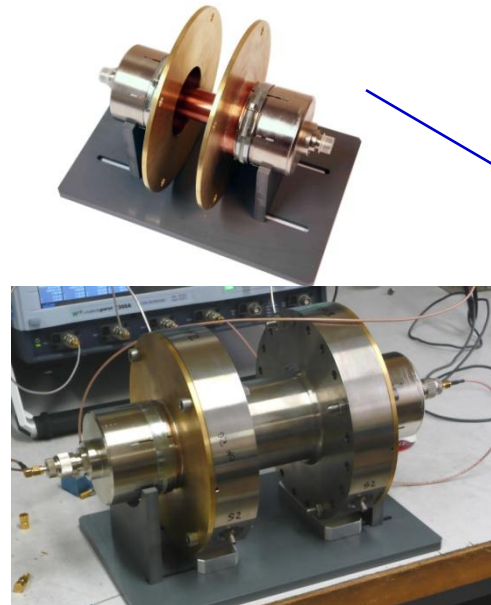
Pick-up 1



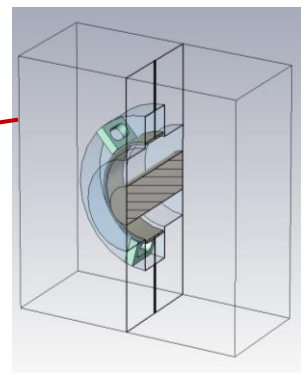
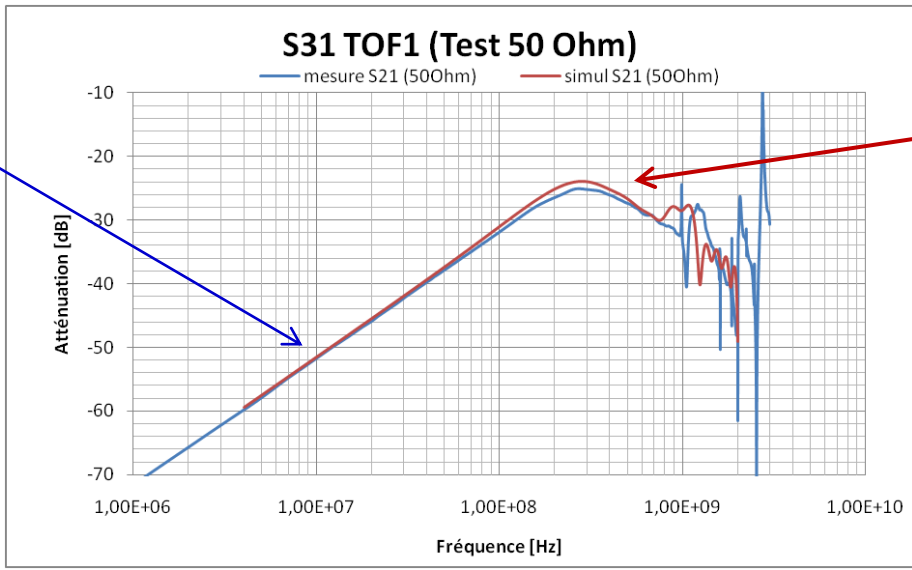
Pick-up 2 and 3



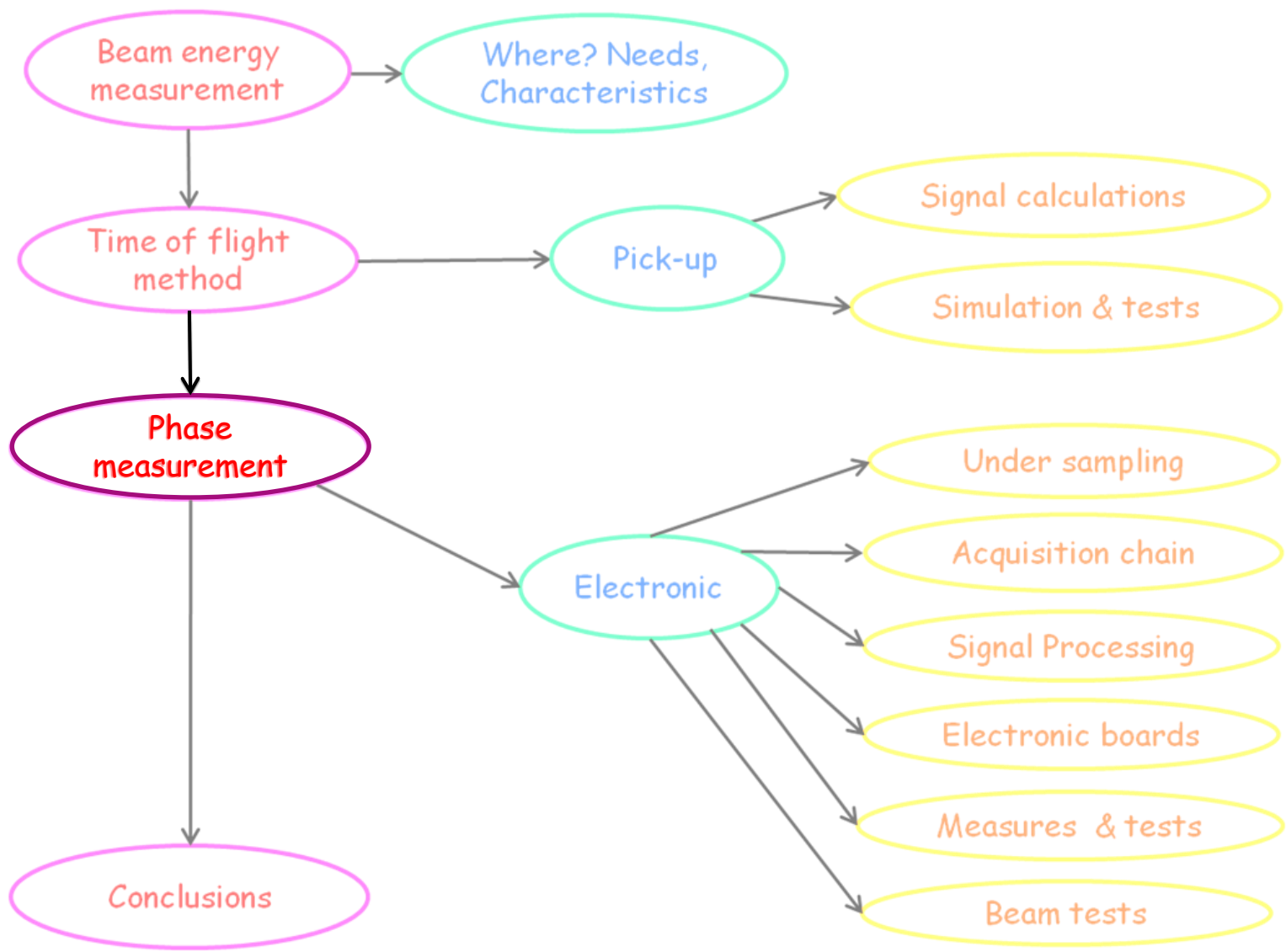
Test Bench



Simulation with CST μ waves Studio

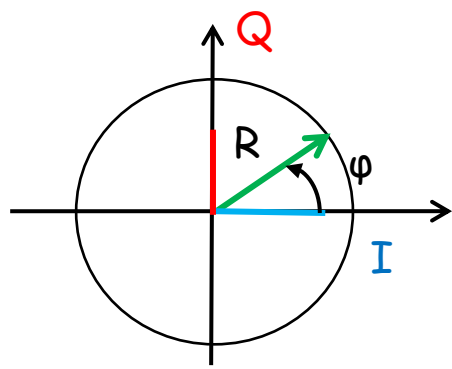


The test bench is a coaxial line witch allows to send a RF signal in the middle of the pick-ups. The simulated curve (in red) is very close to the measured curve (in blue).



The phase measurement of a pick-up signal consists in measuring the phase of one signal harmonic and a reference. In our case, the harmonic 1 or 2 will be used to measure the phase.

Sinusoidal RF signal



$$r(t) = R \sin(\omega t + \varphi)$$

$$r(t) = \underbrace{R \cos(\varphi)}_{I} \sin(\omega t) + \underbrace{R \sin(\varphi)}_{Q} \cos(\omega t)$$

I : In phase component

Q : Quadrature phase component

$$I = R \cos(\varphi)$$

$$Q = R \sin(\varphi)$$

$$r(t) = I \sin(\omega t) + Q \cos(\omega t)$$

$$R = \sqrt{I^2 + Q^2}$$

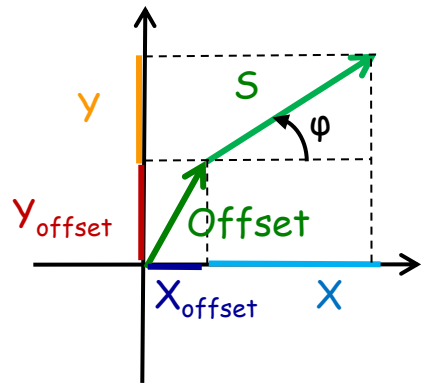
$$\varphi = \text{atang}\left(\frac{Q}{I}\right)$$

Periodical signal = sum of harmonics

$$s(t) = \sum_{n=0}^{\infty} S_n \sin(n \cdot \omega t + \varphi_n) \quad n: \text{harmonic number}$$

$$s(t) = \sum_{n=0}^{\infty} [I_n \sin(n \cdot \omega t) + Q_n \cos(n \cdot \omega t)] \quad S_n = \sqrt{I_n^2 + Q_n^2} \quad \varphi_n = \text{atang}\left(\frac{Q_n}{I_n}\right)$$

Phase measurements can be disturbed or limited by an offset and a noise.
 An offset is a disturbance which is superposed on the signal to be measured.



Solution: The offset deduction is made by measuring X and Y with and without the beam.

$$X_{\text{beam_off}} = X_{\text{offset}}$$

$$Y_{\text{beam_off}} = Y_{\text{offset}}$$

$$X_{\text{beam_on}} = X + X_{\text{offset}}$$

$$Y_{\text{beam_on}} = Y + Y_{\text{offset}}$$

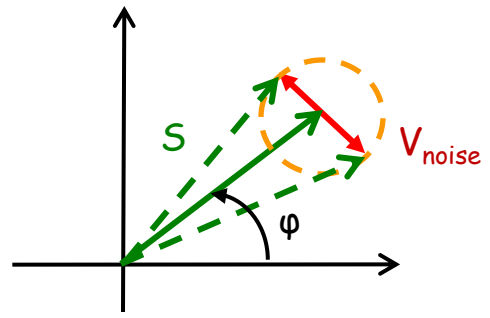
$$S = \sqrt{(X_{\text{beam_on}} - X_{\text{beam_off}})^2 + (Y_{\text{beam_on}} - Y_{\text{beam_off}})^2}$$

$$\varphi = \arctan\left(\frac{Y_{\text{beam_on}} - Y_{\text{beam_off}}}{X_{\text{beam_on}} - X_{\text{beam_off}}}\right)$$

A noise is a random signal defined by a standard deviation σ .
 $p(V)$: Amplitude Probability

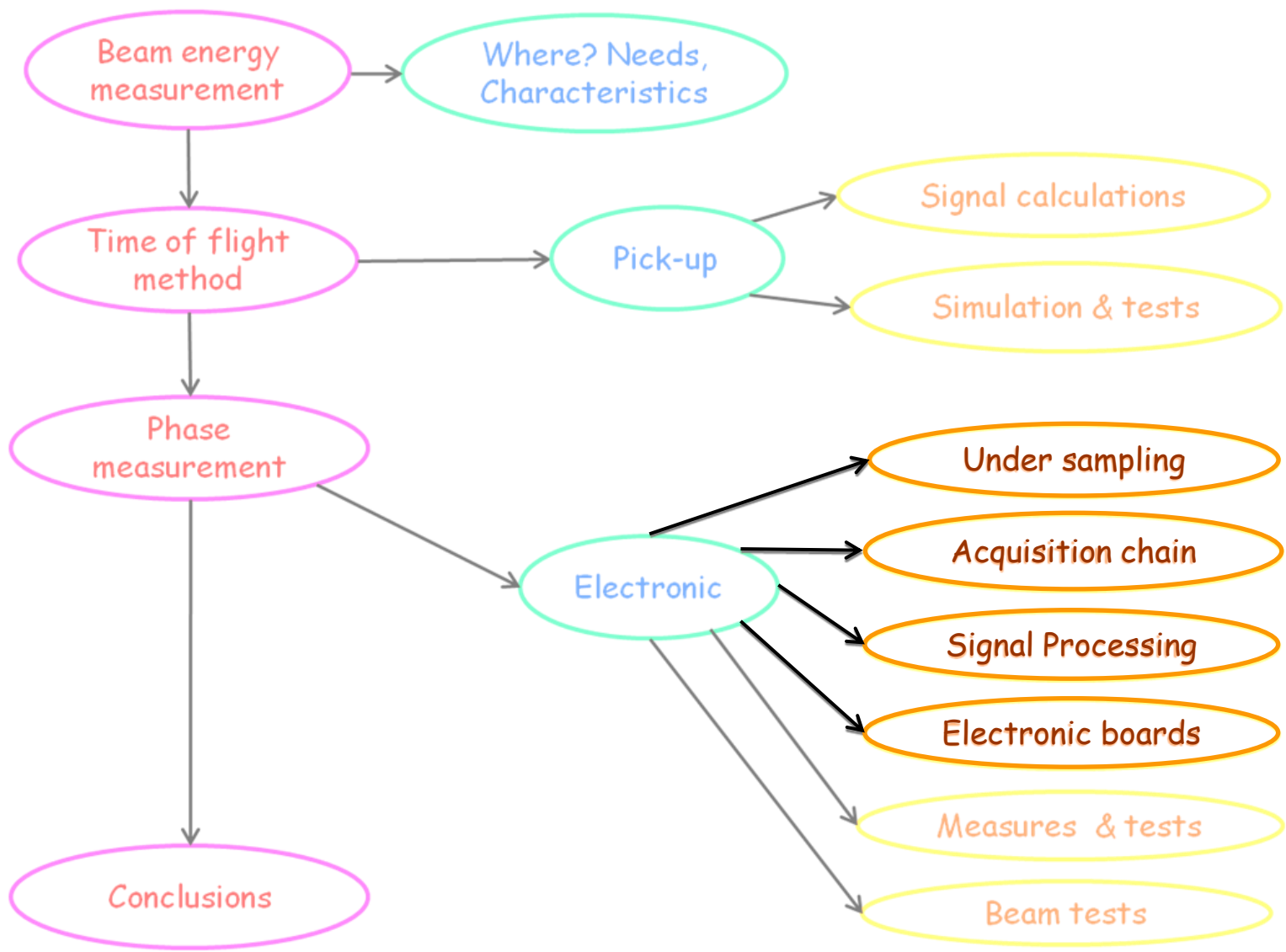
$$p(V) = \frac{1}{\sigma\sqrt{2\pi}} e^{-\frac{1}{2}\left(\frac{V}{\sigma}\right)^2}$$

$$\varphi_{\text{noise}} \approx \frac{V_{\text{noise}}}{S}$$

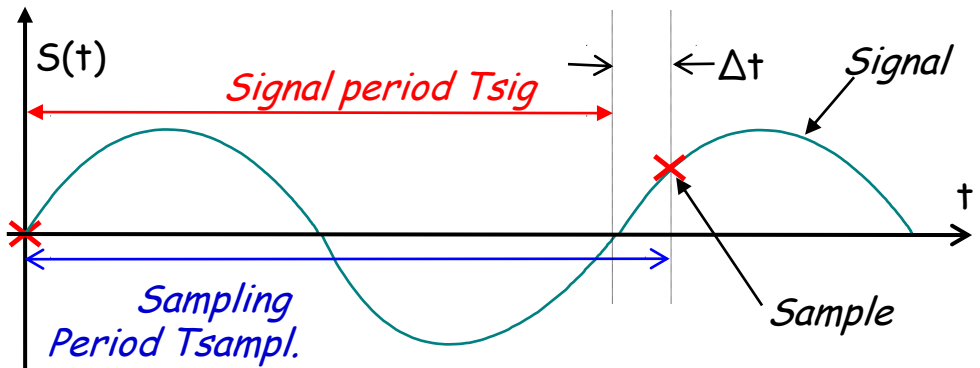


Solution: Filter and/or average signals X and Y

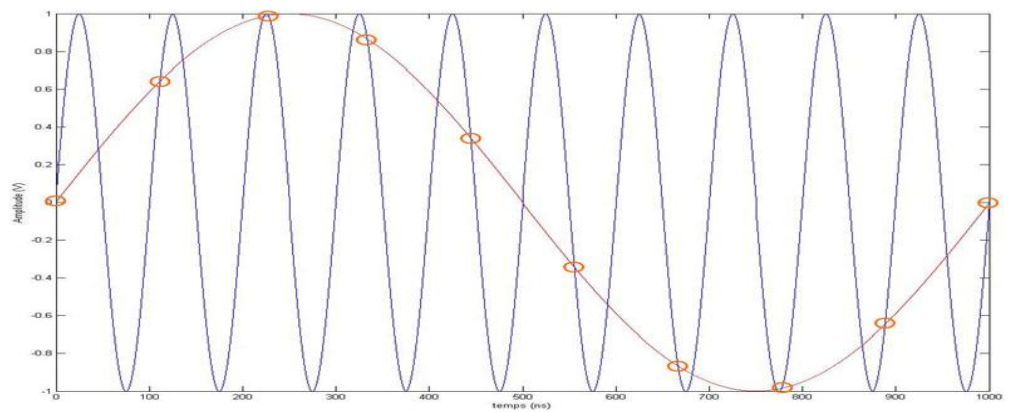
$$\sigma_{\text{average}} = \frac{\sigma}{\sqrt{n_{\text{average}}}}$$



When the frequency of a periodical signal is well known, it is possible to use the undersampling technique to acquire the signal. In our case, one value per period is acquired with a slight shift in time.



Example of the signal transposed at a lower frequency



This method allows to have enough time for the data processing.

Undersampling in the frequency domain

$$\Delta t = T_{\text{sampl.}} - T_{\text{sig.}} \quad \Delta f = F_{\text{sig.}} - F_{\text{sampl.}} = \frac{1}{T_{\text{sig.}}} - \frac{1}{T_{\text{sampl.}}}$$

Nb: Number of points used to reconstruct the signal

$$Nb = \frac{T_{\text{sign.}}}{\Delta t} = \frac{T_{\text{sign.}}}{T_{\text{sampl.}} - T_{\text{sign.}}} = \frac{F_{\text{sampl.}}}{F_{\text{sign.}} - F_{\text{sampl.}}} = \frac{F_{\text{sampl.}}}{\Delta F}$$

The sampling frequency is equal to: $F_{\text{sampl.}} = F_{\text{sig.}} \frac{Nb}{Nb + 1}$

The equivalent frequency is: $F_{\text{equi.}} = F_{\text{sig.}} * Nb$

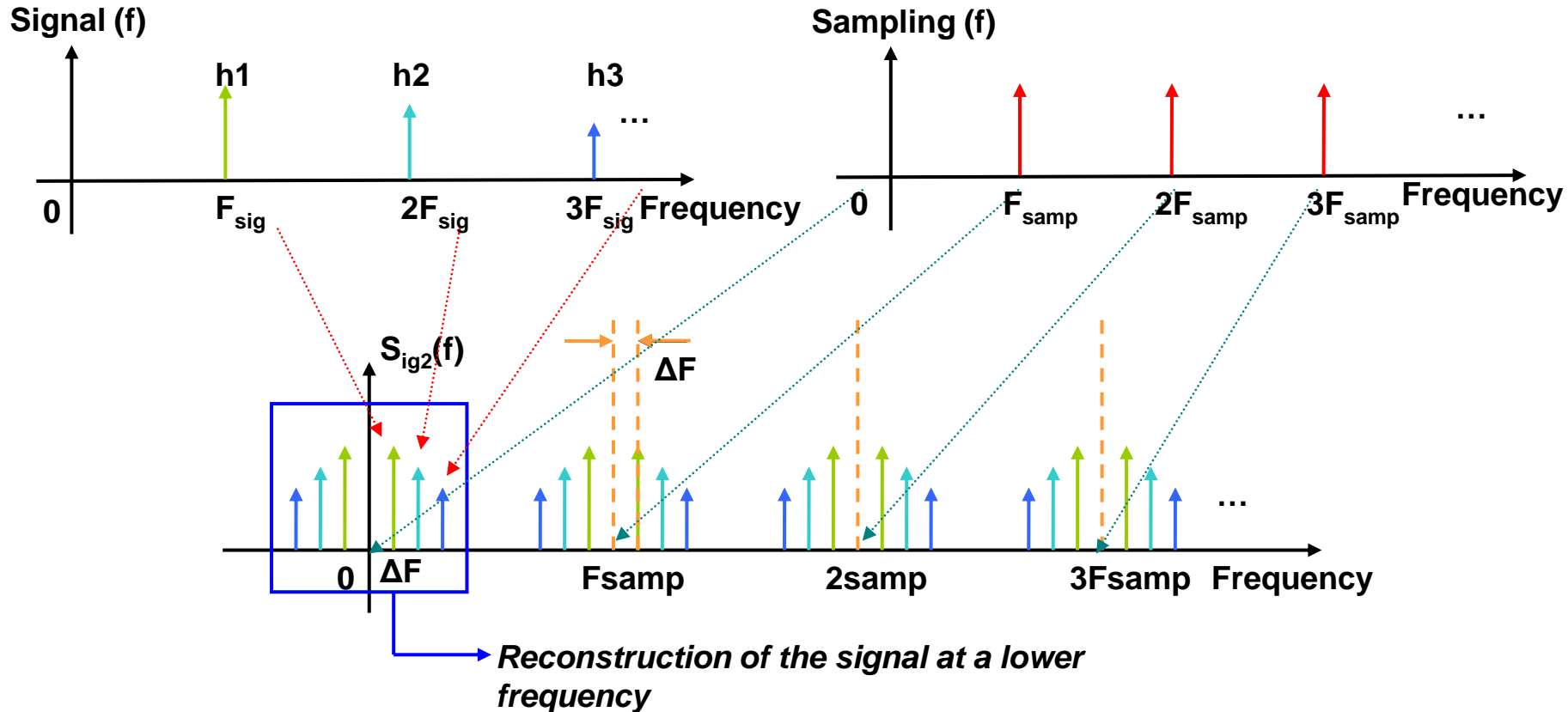
Example:

A 88 MHz signal is undersampled at a sampling frequency allowing reconstruct the signal by 256 points.

$$F_{\text{sampl.}} = F_{\text{sig.}} * \frac{256}{257} = 87,66 \text{ MHz}$$

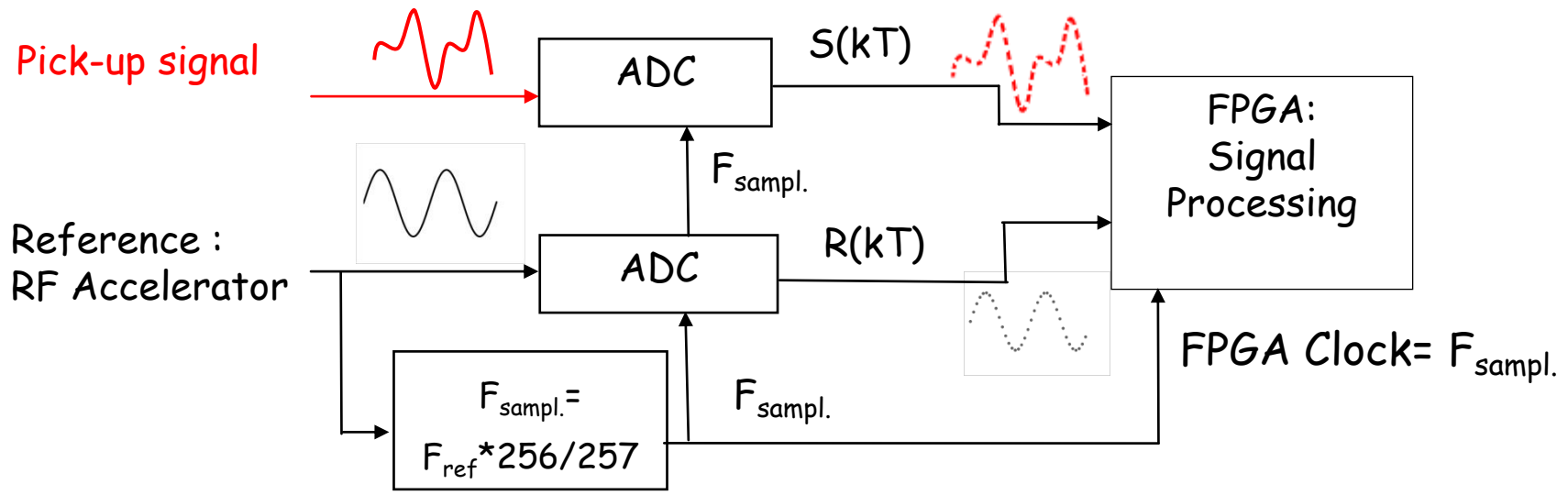
$$F_{\text{equi.}} = 88 * 256 = 22,5 \text{ GHz}$$

Undersampling in the frequency domain



The undersampling method allows to transpose at the lower frequencies the harmonics of the input signal.

Pick-up signals and the RF reference are sampled in the same time.



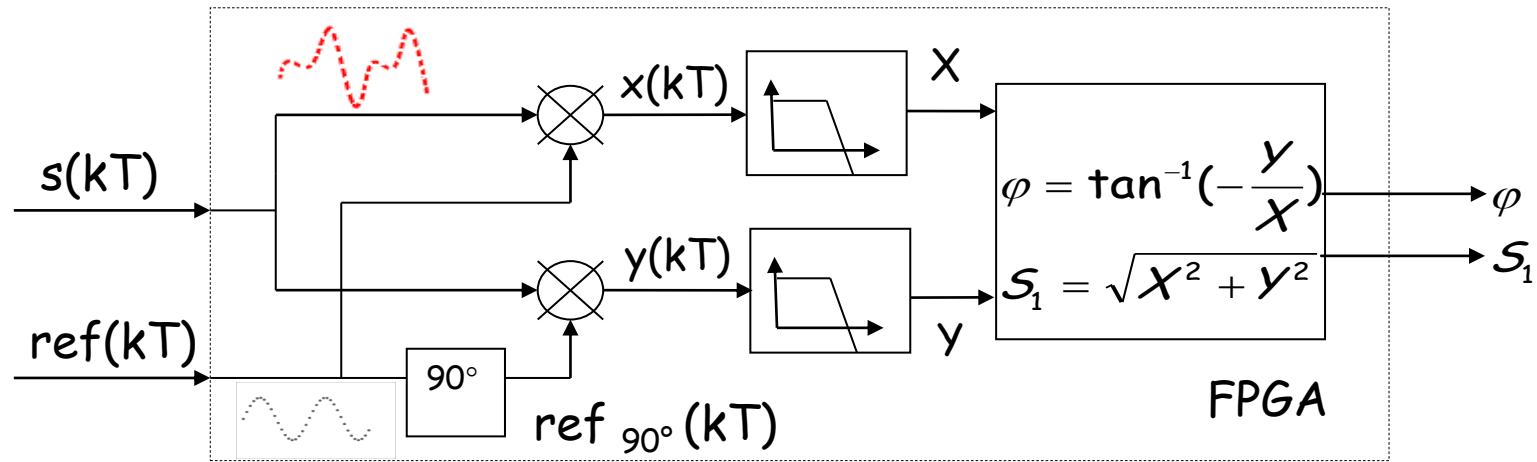
T: Sampling period $T = \frac{1}{F_{sample}}$

$F_{sampl.}$ is calculated from the reference RF with a ratio which gives $N_b=256$. N_b is the number of samples necessary to reconstitute a signal period.

Reference RF SPIRAL2 = 88,05 MHz
 $F_{sampl.} \sim 87,7$ MHz

The sampling of signals and the reference at the same time allows not be sensitive to the sampling frequency jitter.

The signal processing consists in designing a lock-in amplifier function.



$$s(kT) = \sum_{n=0}^{\infty} [I_n \sin(n \cdot \omega kT) + Q_n \cos(n \cdot \omega kT)]$$

$$\text{ref}(kT) = R \sin(\omega kT) \quad \text{ref}_{90^\circ}(kT) = R \sin(\omega kT + 90^\circ) = R \cos(\omega kT)$$

$$x(kT) = s(kT) * \text{ref}(kT) \quad y(kT) = s(kT) * \text{ref}_{90^\circ}(kT)$$

The low pass filters (or average) take only the DC part of x(kT) and y(kT).

$$X = \frac{R I_1}{2} = \frac{R S_1 \cos \varphi}{2} \quad y = \frac{R Q_1}{2} = \frac{R S_1 \sin \varphi}{2}$$

The low pass filter determines the detection bandwidth.

$$X = \frac{R I_1}{2} = \frac{R S_1 \cos \varphi}{2}$$

$$Y = \frac{R Q_1}{2} = \frac{R S_1 \sin \varphi}{2}$$

From X and Y, we can calculate the harmonic1 modulus S_1 and the phase φ_1 .

$$I_1 = \frac{2X}{R} \quad Q_1 = \frac{2Y}{R}$$

$$S_1 = \sqrt{I_1^2 + Q_1^2} = \sqrt{\left(\frac{2X}{R}\right)^2 + \left(\frac{2Y}{R}\right)^2}$$

$$\varphi_1 = \text{atang}\left(\frac{Q_1}{I_1}\right) = \text{atang}\left(\frac{Y}{X}\right)$$

S_1 : Module of the first harmonic of $s(t)$

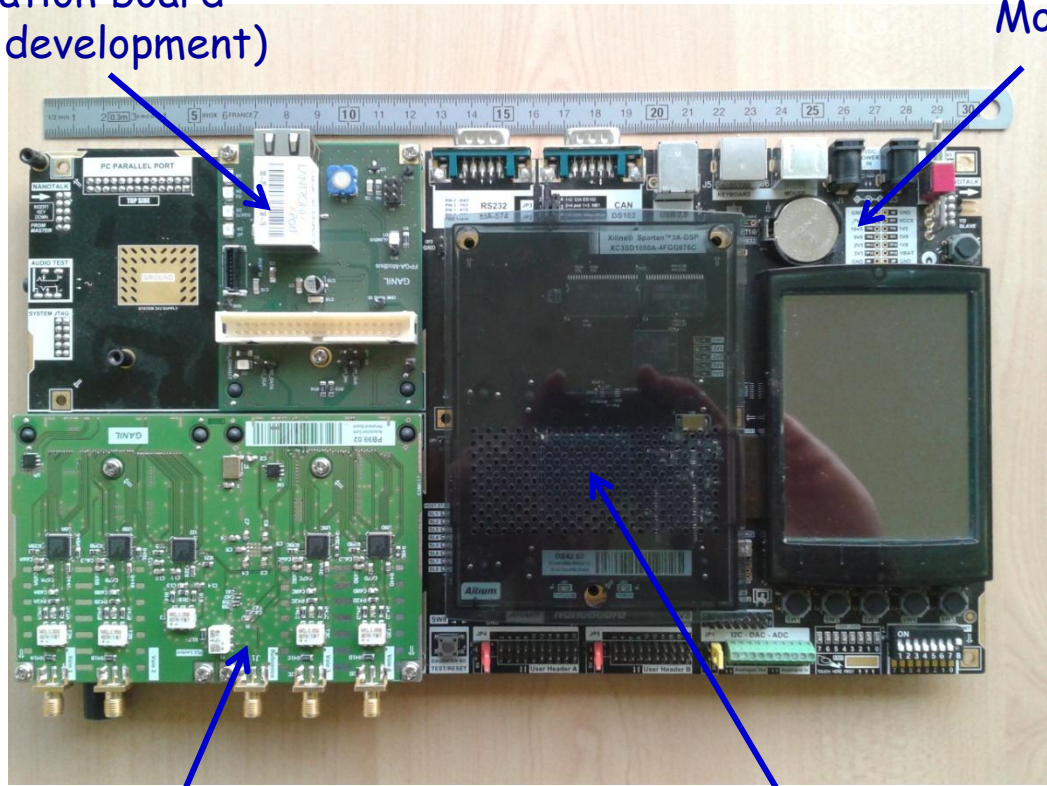
φ_1 : Phase of the first harmonic of $s(t)$

By changing the frequency of the reference (n.F), the coefficients S_n and φ_n can be calculated in the same way.

To simplify electronic developments, a commercial board is used to carry out the signal processing. (Nanobard NB2 of the Altium Compagny). Its flexibility and its tight integration with the Altium Designer software improve and simplify the system design.

Communication board
(GANIL's development)

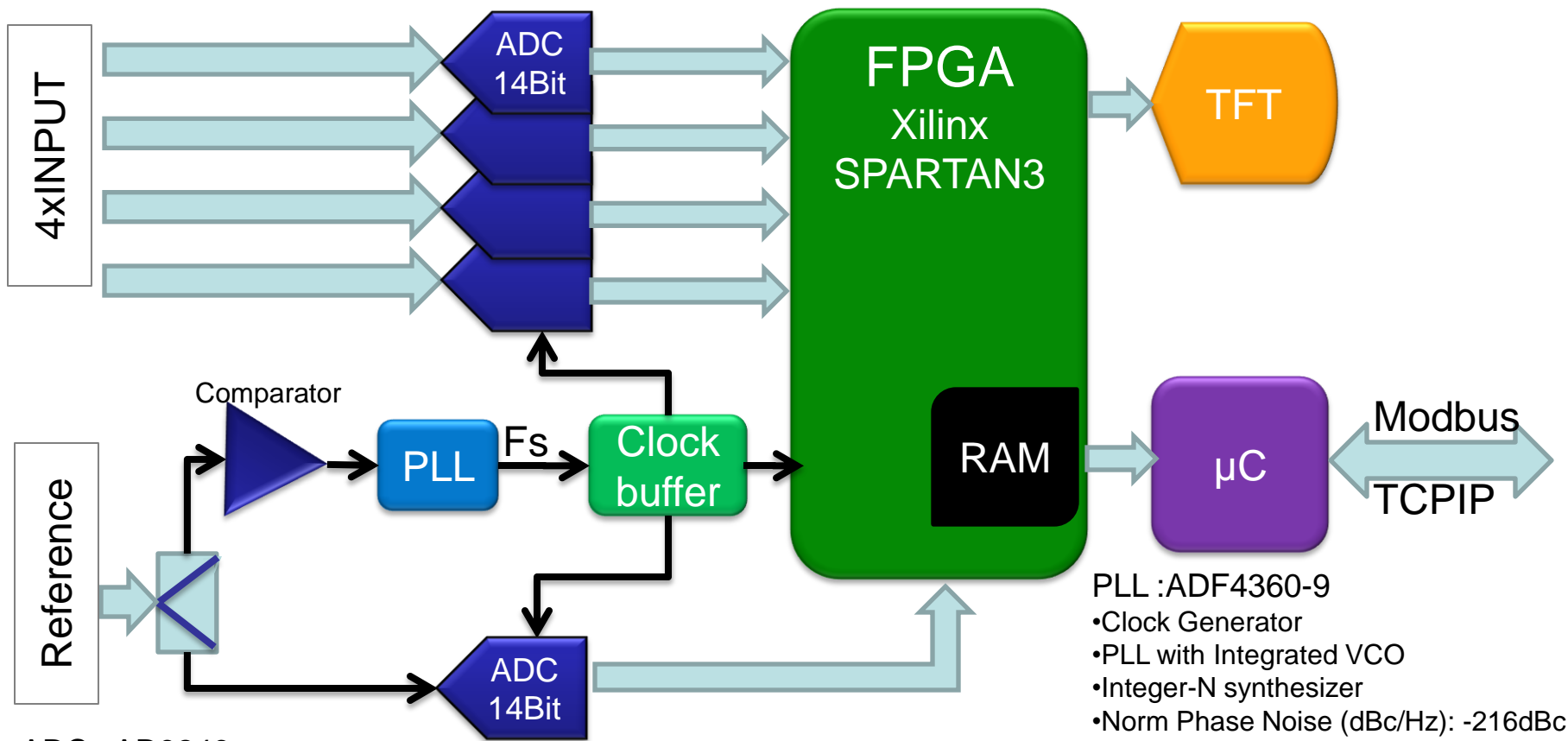
Mother board



Acquisition board
(GANIL's development)

Daughter board
Spartan3 Xilinx FPGA

Electronic synoptic



ADC : AD9246

- 14-Bit, 125 MSPS
- 1.8 V Analog-to-Digital Converter
- Low power: 395 mW @ 125 MSPS
- Differential input with 650 MHz bandwidth
- SNR = 71.7 dBc

Clock BUFFER: IDT5T93GL06

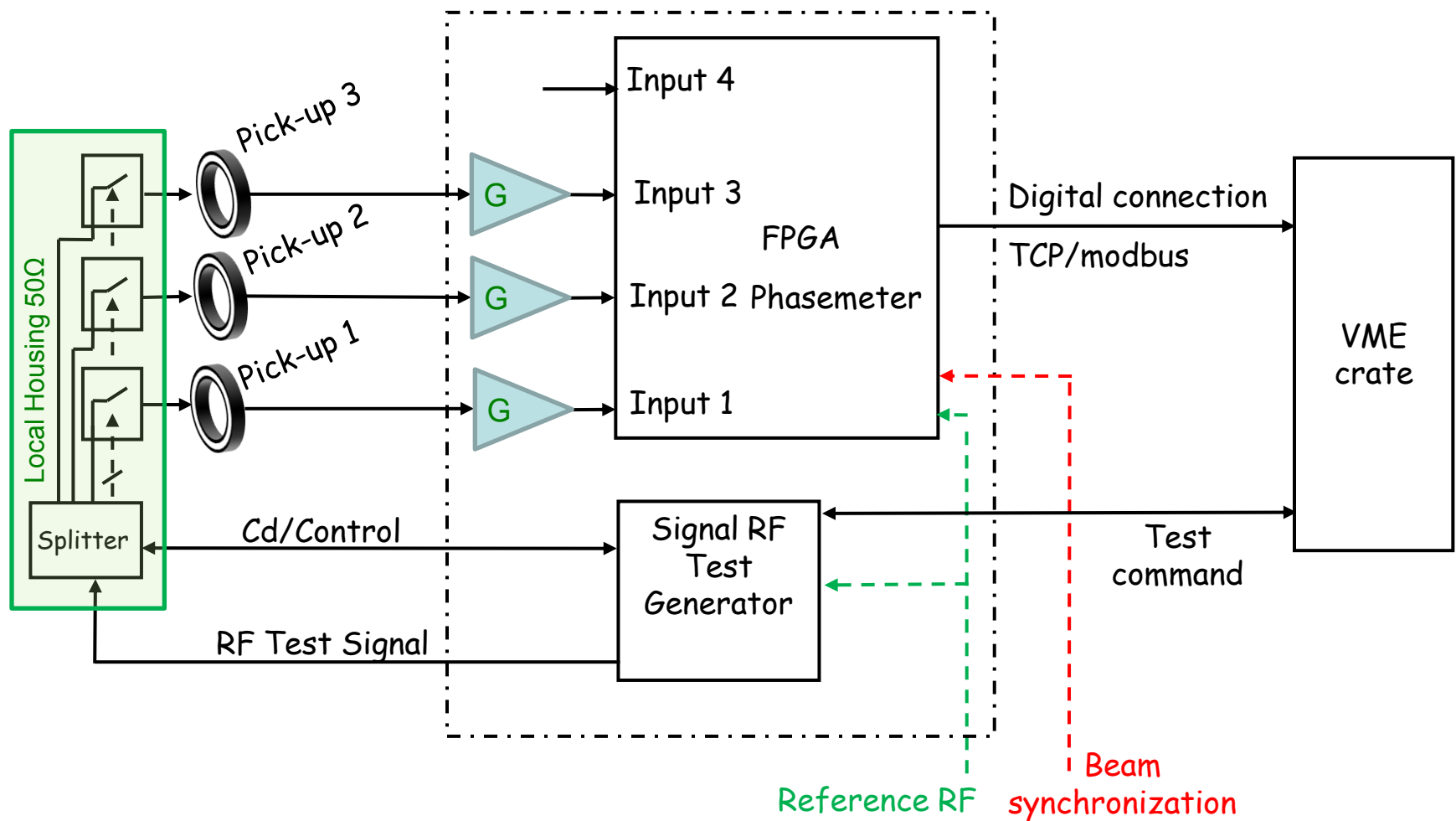
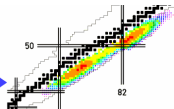
- 2.5V LVDS 1:6 GLITCHLESS
- Guaranteed Low Skew < 25ps (max)
- RMS Additive Phase Jitter 0.159 ps

PLL : ADF4360-9

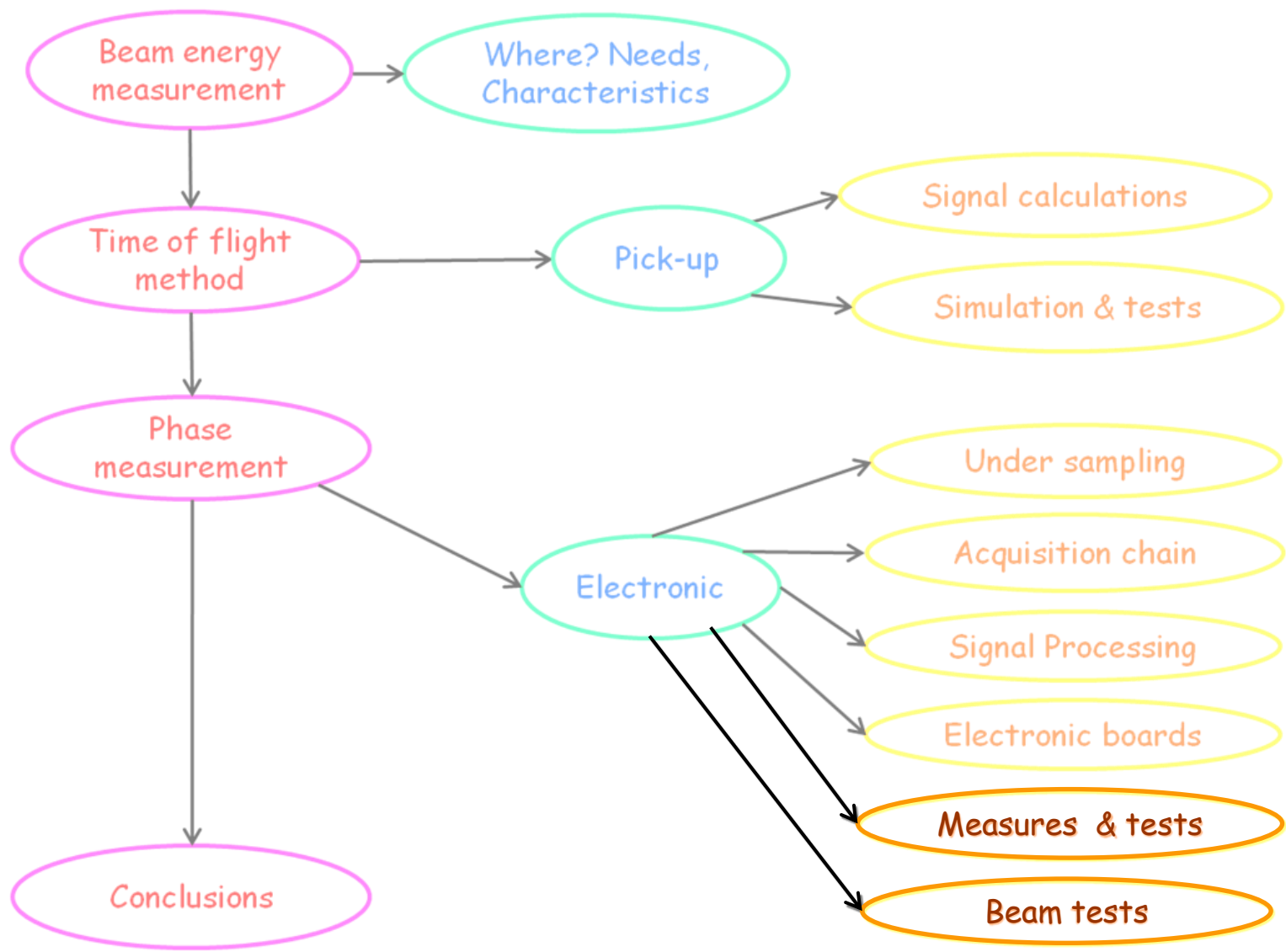
- Clock Generator
- PLL with Integrated VCO
- Integer-N synthesizer
- Norm Phase Noise (dBc/Hz): -216dBc

Comparators: ADCMP604

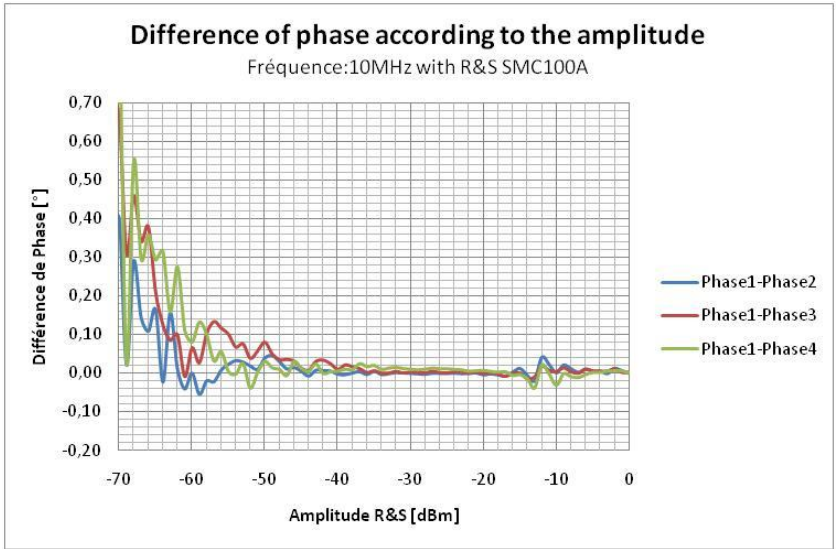
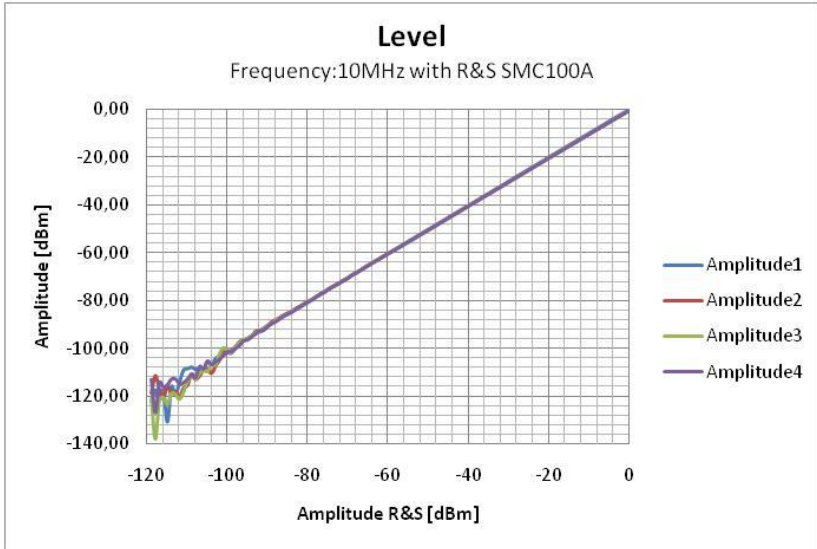
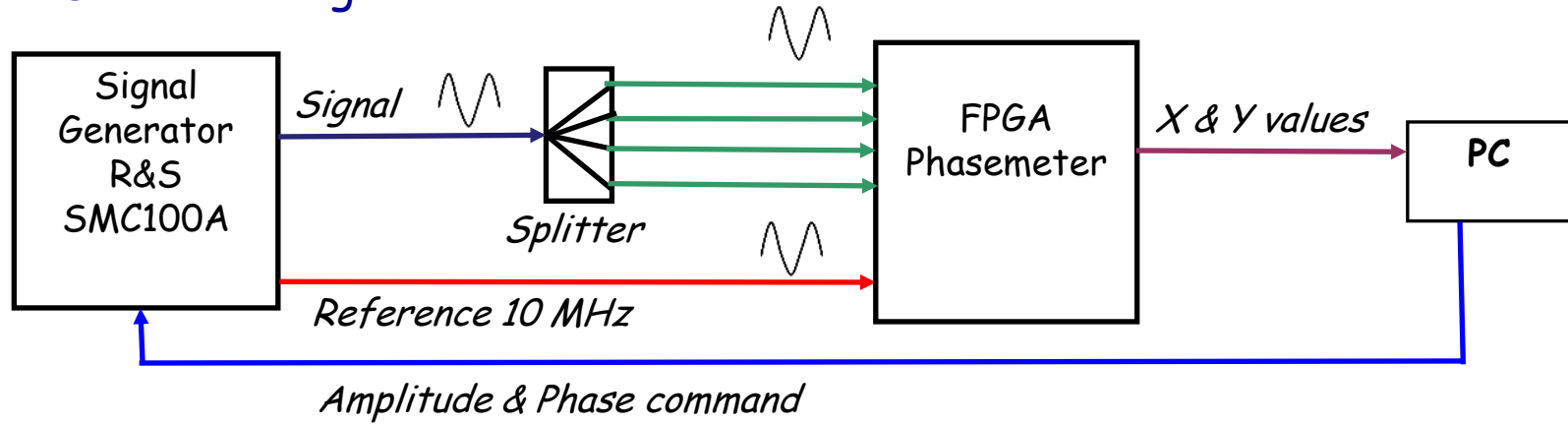
- Rail-to-Rail
- Very Fast, 2.5 V
- Propagation Delay Skew 70ps



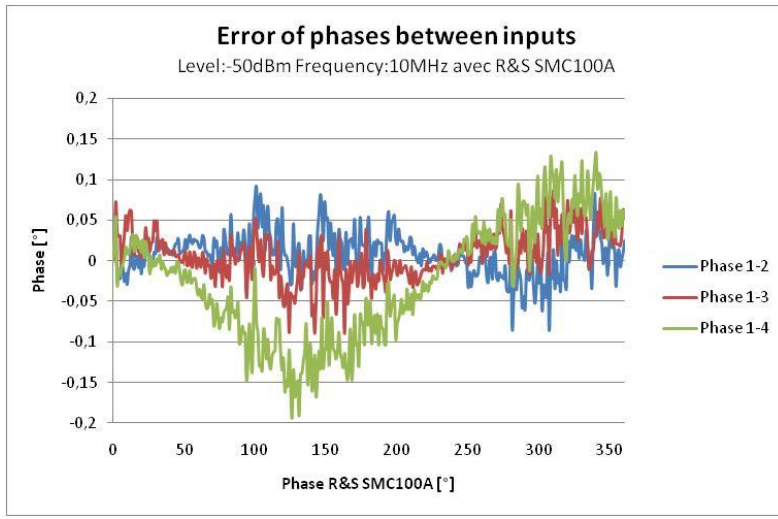
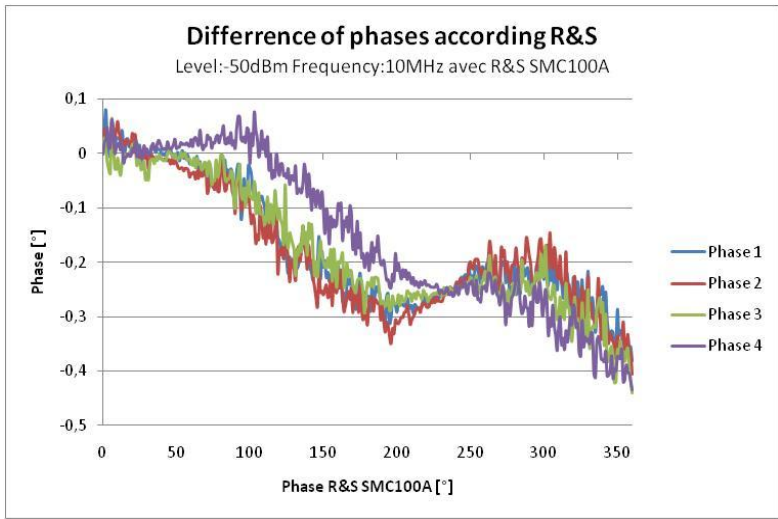
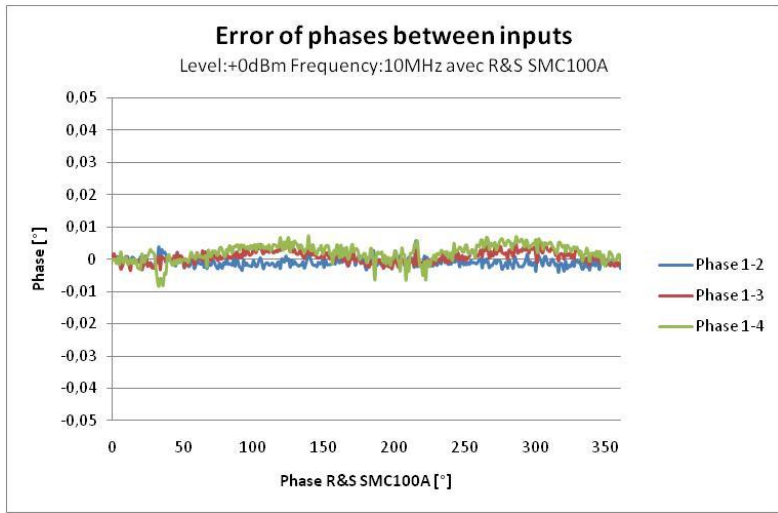
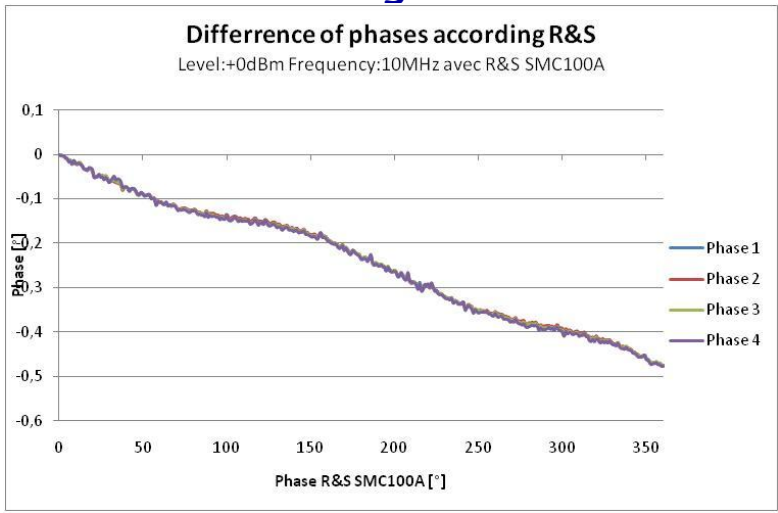
RF Amplifier: HD24503 from HD Communication Corp. G=42dB



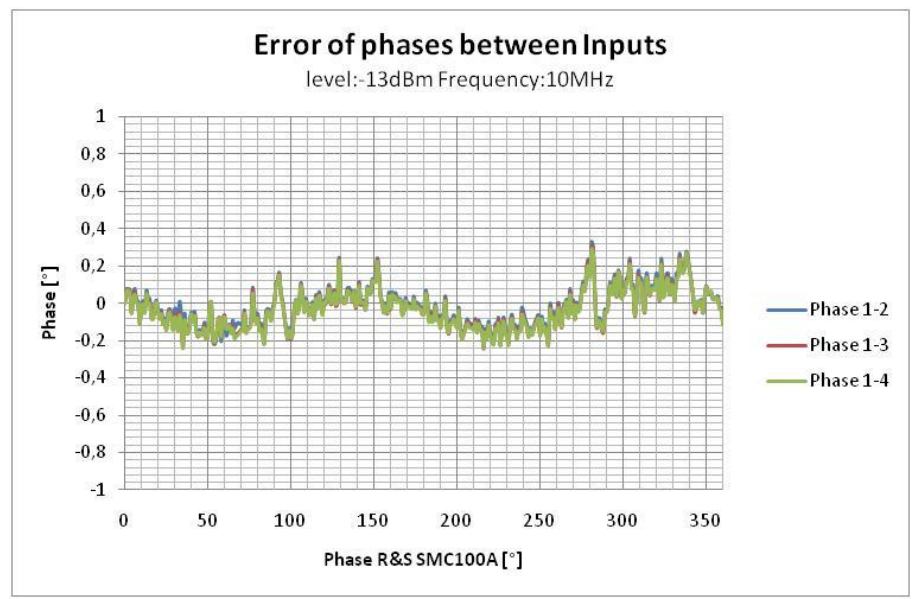
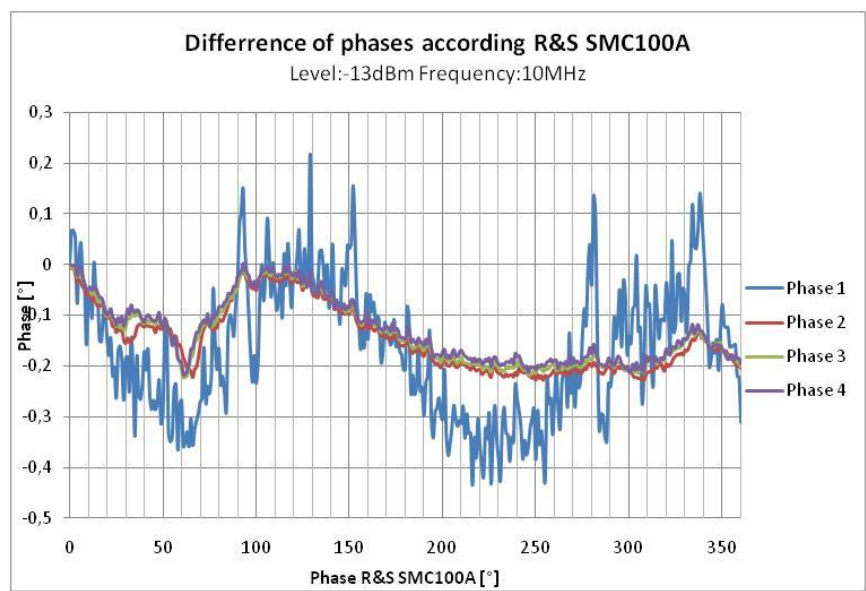
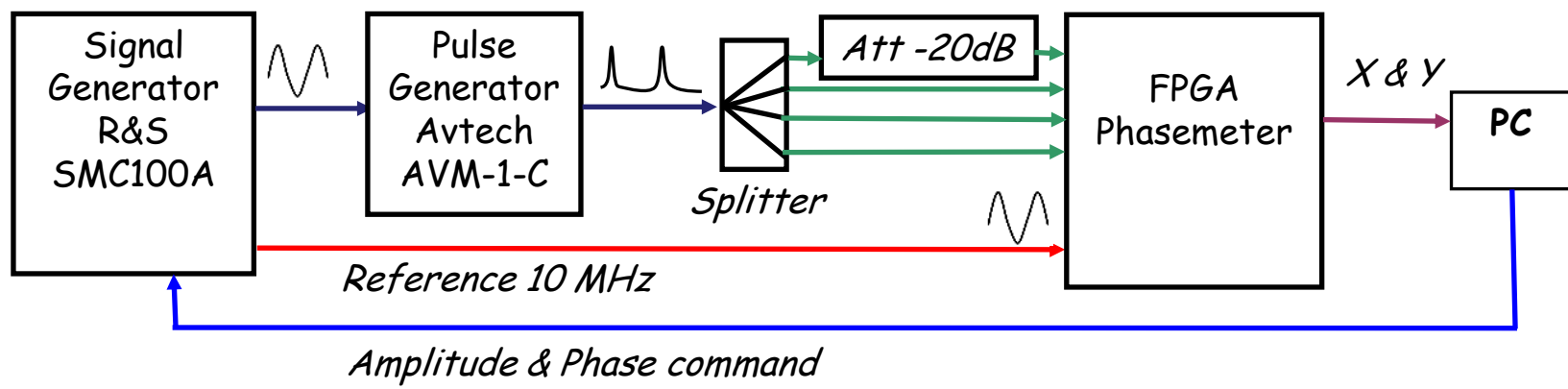
Sinusoidal signal



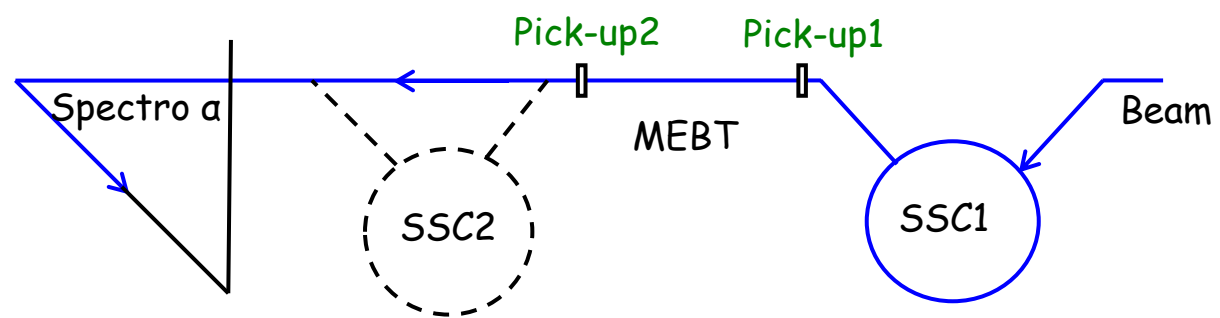
Sinusoidal signal



Pulse signal



Beam Tests on the GANIL accelerator were planned to compare beam energy measurements by time of flight with the FPGA phasemeter and the spectrometer method.

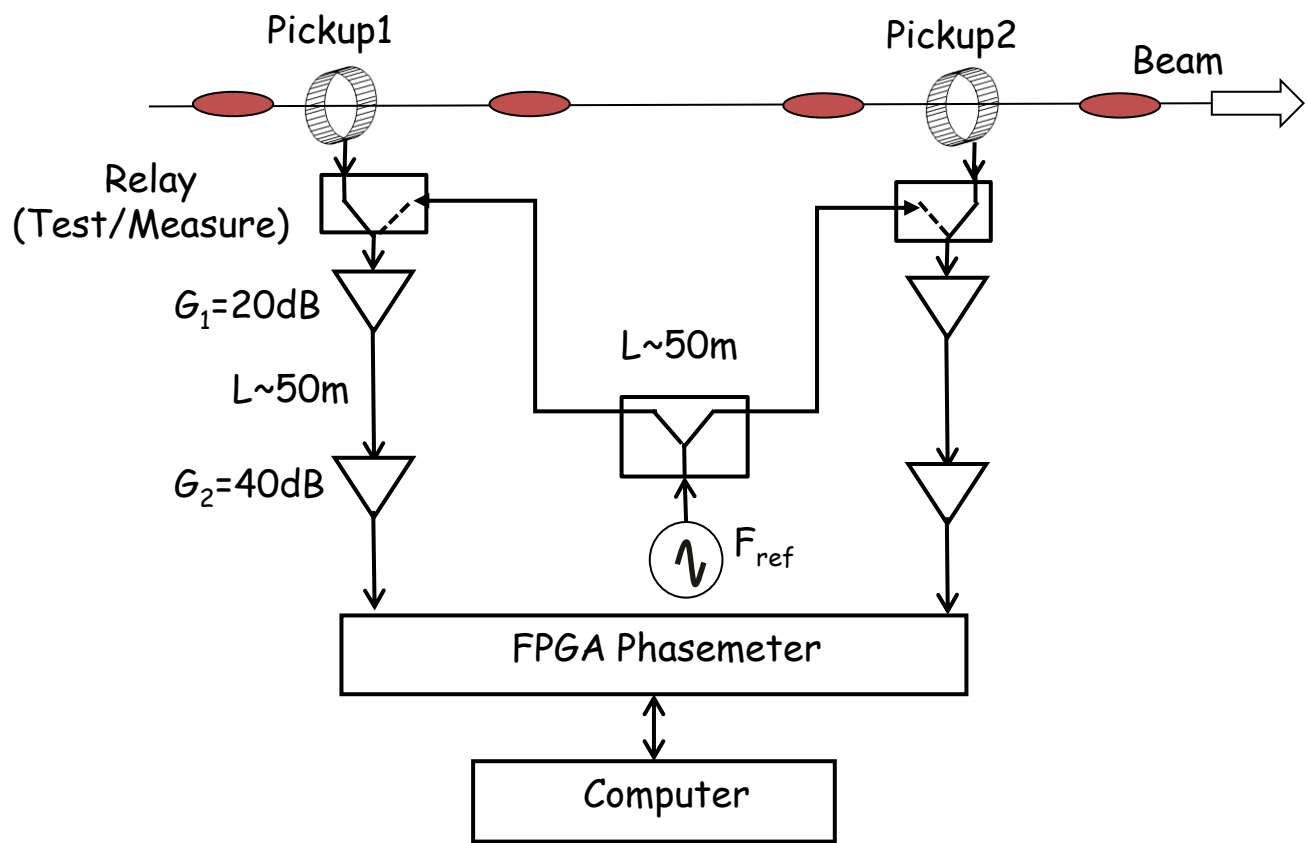


Scheme of the GANIL's Accelerator

SSC : Separated Sector Cyclotron

		MEBT
Energy	E (MeV/A)	11
Velocity	$\beta=v/c$	$\sim 0,15$
Frequency	F_{acc} (MHz)	7,5 to 14
Length	L_{acc} (m)	3,77
Length	L_{12} (m)	9,1222
Bunch Number		2

System diagram



Relays can be switched to inject a test signal. This calibration signal gives the possibility to measure the phase difference between the two chains.

A Labview program manages the following:

- Communication with the FPGA phasemeter
- Graphical User Interface (GUI)
- A phase difference calculation with an offset correction
- A TOF energy calculation
- An energy difference calculation between the two energy measurements

Beam parameters

Parametre

Soufre

Z(proton) 16, N(Electron) 16, Symbole S, A(Nucleon) 32

Masse Atomique 35,967081 u.m.a, Masse Atomique corrigé 35,962689 u.m.a

Fréquence machine 32,31M, Energie Théorique 11,4445 MeV/A

ΔE (T.O.F.-théorique) 0,061 MeV/A, $\Delta E/E$ (T.O.F.-théorique) 5,3 ‰

Brho

Bp théorique 2,19736 T/m	Bp mesuré 2,19774 T/m
vitesse 47,1629M m/s	vitesse 46,597743M m/s
γ (Gamma) 1,01229692	γ (Gamma) 1,01230314
Ecart de ϕ Bp 867,551	Ecart de ϕ total 865,443
Energie 11,4445 MeV/A	Energie 11,4484 MeV/A
ΔE (Bp) 0 MeV/A	$\Delta E/E$ (Bp) 0,3 ‰

T.O.F.

TOF 195,269n s

vitesse 46,7113M m/s

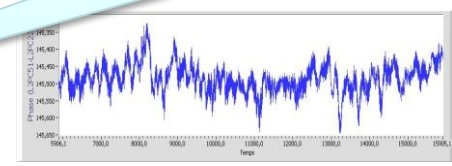
γ (Gamma) 1,01236429

Ecart de ϕ total 865,443

Energie 11,5053 MeV/A, σ 235,55u MeV/A

ΔE (TOF-Bp) 0,06 MeV/A, $\Delta E/E$ (TOF-Bp) 5 ‰

Phase difference calculation with offset correction



TOF energy calculation

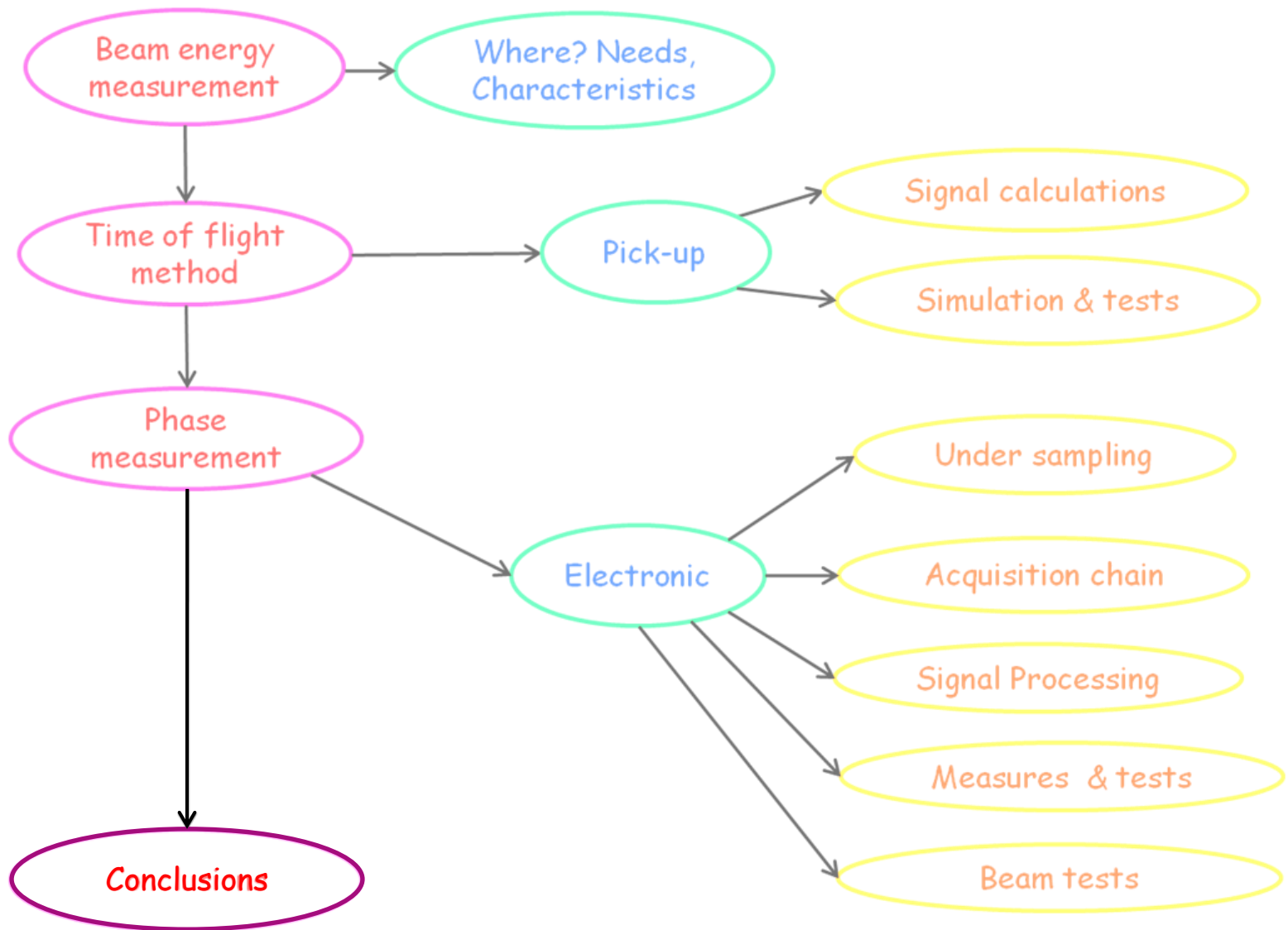
TOF energy calculation results. The top panel shows phase difference plots for LRPC22 and LRPC31. The middle panel shows a histogram of TOF values with a peak at approximately 11,5053 ns. The bottom panel shows energy difference plots for LRPC22 and LRPC31, with a peak at approximately 11,4484 MeV/A.

Energy difference calculation between the two energy measurement method

Date: 21/06/2011
 Beam Parameters: $^{36}\text{Sulfur}^{8+}$
 Energy: 11,4445 MeV/A
 Beam Intensity: $3\mu\text{Ae}$

Energy measured by the spectrometer: 11,4484 MeV/A

Measure number	phase difference	total phase difference	total phase difference with offset compensation	Energy calculated from phase measurements	Energy gap between TOF and spectrometer method ($^{\circ}/^{\circ}$)
1	145,56	865,56	868,26	11,4308	-1,54
2	145,44	865,44	868,14	11,4339	-1,27
3	145,39	865,39	868,09	11,4353	-1,15
4	145,31	865,31	868,01	11,4376	-0,95
5	145,31	865,31	868,01	11,4374	-0,96



The accurate phase measurement requires

- The necessity to subtract the offset
- The necessity to calibrate the phase difference between each channel

- The undersampling acquisition gives the possibility to calculate the phase of several harmonics in the same time.
- The direct sampling of the signal works well for large pulses. In the case of narrow pulses, it is necessary to filter the signal upstream.
- The sampling of signals and the reference at the same time allows not be sensitive to the sampling frequency jitter.

Next Steps:

- Use a FPGA with DSP functions to increase the computing power
- Add the measurement of the harmonic2 phase
- Integrate electronics in a crate
- Change the reference frequency (10 MHz to 88,05 MHz)
- Develop and validate the TCP/modbus communication
- Develop the Command/control interface in EPICS (Control system)
- Update the FPGA program to integrate safety functions (beam energy surveillance at the LINAC exit)

Thank You for your attention !

- [1] Beam Instrumentation, J. Bosser, CERN-PE-ED001-92 Revised nov. 1994
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- [3] Beam Instrumentation and Diagnostics – Peter Strehl – Editeur Springer Berlin 2006
- [4] Application Notes : About Lock-in Amplifiers – Stanford Research
<http://www.thinksrs.com/support/app.htm>
- [5] C. Jamet et al., Phase and amplitude measurement for the SPIRAL2 Accelerator, DIPAC09, Basel, Switzerland
- [6] W. Le Coz, SPIRAL2 Beam Energy Measurement, DIPAC11, Hamburg, Germany